


<b>Search Notes</b> 	<b>Application/Control No.</b> 10563054	<b>Applicant(s)/Patent Under Reexamination</b> MEIER, MARKUS
	<b>Examiner</b> Cruz, Leslie P	<b>Art Unit</b> 2826

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
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INTERFERENCE SEARCH			
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